

1 **PC37.30.4™/D8**  
2 **Draft Standard for Test Code for**  
3 **Switching and Fault Making Tests for**  
4 **High-Voltage Interrupter Switches,**  
5 **Interrupters or Interrupting Aids Used**  
6 **on or Attached to Switches Rated for**  
7 **High-Voltage AC Above 1000 Volts**

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1 **Abstract:** Test code is specified for switching (except capacitive current) and fault making  
2 tests for switching devices for alternating current, rated above 1000 volts and used  
3 indoors, outdoors, or in enclosures.

4  
5 **Keywords:** Interrupting switches, high voltage switches, indoor switches, outdoor  
6 switches  
7

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# 1 Introduction

2 This introduction is not part of IEEE PC37.30.4 Draft Standard for Test Code for Switching and Fault Making Tests for  
3 High-Voltage Interrupter Switches, Interrupters or Interrupting Aids Used on or Attached to Switches Rated for High-  
4 Voltage AC Above 1000 Volts.

5 This standard provides test code for switching (except capacitive current) and fault making tests for  
6 switching devices for alternating current, rated above 1000 volts and used indoors, outdoors, or in  
7 enclosures.

8 Evolution of various standards has resulted in the need to split the content of IEEE Std 1247 – 2005 into  
9 two new proposed standards, C37.30.3 and C37.30.4. The proposed document C37.30.3 will become the  
10 basic standard for High Voltage Interrupter Switches, Interrupters or Interrupting Aids used on or attached  
11 to High Voltage Switches. The proposed document C37.30.4 will provide a common test code for  
12 equipment described in C37.30.3 and other product standards.

13  
14

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26 Editing instructions, change markings, and this NOTE will not be carried over into future editions because the changes  
27 will be incorporated into the base standard.

## 1 Overview

### 2 1.1 Scope

3 This standard provides the test code for switching (except capacitive current) and fault making tests for  
4 high voltage interrupter switches, interrupters or interrupter aids for use on switches rated above 1000 V  
5 AC and used indoors, outdoors, or in enclosures for non-fault current interrupting for which an interrupting  
6 duty is assigned.

### 7 1.2 Purpose

8 The purpose of this standard is to provide the test code for switching and fault making tests for switching  
9 devices not covered by other standards.

## 10 2. Normative references

11 The following referenced documents are indispensable for the application of this document (i.e., they must  
12 be understood and used, so each referenced document is cited in text and its relationship to this document is  
13 explained). For dated references, only the edition cited applies. For undated references, the latest edition of  
14 the referenced document (including any amendments or corrigenda) applies.

15 Accredited Standards Committee C2-2002, National Electrical Safety Code (NESC®) <sup>1</sup>

16 IEEE Std C37.20.2, IEEE Standard For Metal-Clad And Station-Type Cubicle Switchgear (ANSI)

17 IEEE Std C37.20.3, IEEE Standard For Metal-Enclosed Interrupter Switchgear (ANSI)

18 IEEE Std C37.20.4, Standard For Indoor AC Medium Voltage Switches For Use In Metal-Enclosed  
19 Switchgear

20 IEEE Std C37.74, IEEE Standard Requirements for Subsurface, Vault, and Padmounted Load-  
21 Interrupter Switchgear and Fused Load-Interrupter Switchgear for Alternating Current Systems up  
22 to 38 kV.

23  
24 IEEE Std C37.09-1999, IEEE Standard Test Procedure For AC High-Voltage Circuit Breakers Rated On A  
25 Symmetrical Current Basis (ANSI) <sup>2</sup>

26 IEEE Std C37.41 - 1994, Standard Design Tests For High Voltage Fuses, Distribution Enclosed Single-  
27 Pole Air Switches, Fuse Disconnecting Switches And Accessories

28 OSHA Rule 1910.269 - 1994, Electric Power Generation, Transmission, and Distribution: Electrical  
29 Protective Equipment <sup>3</sup>

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### 1 3. Definitions

2 For the purposes of this document, the following terms and definitions apply. The *IEEE Standards*  
3 *Dictionary Online* should be consulted for terms not defined in this clause. <sup>4</sup>

4 **Allowable Continuous Current Class (ACCC) Designation (of an Air Switch):** A code that identifies  
5 the composite curve relating the loadability factor (LF) of the switch to the ambient temperature  $\theta_A$  as  
6 determined by the limiting switch part class designations.

7 **Arc Reach:** The distance from a point midway between the arc extremities to the most remote point of the  
8 arc at the time of its maximum length.

9 **Arcing Horn:** One of a pair of diverging electrodes on which an arc is extended to the point of extinction  
10 after the main contacts of the switching device have parted.

11 **Distribution Class:** A descriptive term used to denote application, restriction, or both to that part of an  
12 electric system between the substation and the customer.

13 **Enclosed Switch:** Switches designated for operation within a housing restricting heat transfer to the  
14 external medium.

15 **Horn-Gap Switch:** A switch provided with arcing horns.

16 **Indoor Switch:** Switches designated for operation inside buildings or weather-resistant enclosures which  
17 do not restrict heat transfer to the ambient.

18 **Interrupter Switch:** A switching device, designed for making specified currents and breaking specified  
19 steady state currents. (HVS, Swg)

20 **Interrupting Aids:** A current-interrupting device that can be attached to an air switch to improve its  
21 interrupting capability. (eg Quick Break Arcing horns; Vacuum, SF6 and Expulsion interrupters)

22 **Lightning Impulse Dry Withstand Voltage:** The crest value of a voltage impulse with a front duration  
23 from less than one to a few tens of microseconds that, under specified conditions, can be applied without  
24 causing flashover or puncture.

25 **Loadability Factor:** The ratio of allowable continuous current at a given ambient temperature to rated  
26 current.

27 **Loadability:** The ratio of allowable continuous current at 25° C ambient temperature to rated continuous  
28 current.

29 **Observable Temperature Rise:** The observable temperature rise of any part of the switch is the steady-  
30 state temperature rise above ambient temperature.

31 **Outdoor Switch:** Switches designated for operation outside buildings or enclosures. Outdoor switches may  
32 be exposed to the weather. Outdoor switches experience no restriction of heat transfer to the ambient.

33 **Peak Withstand Current:** The maximum instantaneous current at the major peak of an offset power  
34 frequency sinusoidal current that a switch is required to carry.

35 **Power Frequency:** The frequency at which a device or system is designed to operate.

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*IEEE Standards Dictionary Online* subscription is available at: <http://ieeexplore.ieee.org/xpls/dictionary.jsp>.

- 1 **Quick break Arcing Horns:** commonly referred to also as a quick break whip – a conductive member  
 2 mounted such that as the main switch blade opens it remains in contact then releases and quickly creates a  
 3 large open gap for improved current interruption compared to arcing horns.
- 4 **Making Current:** The value of the available current at the time the device closes. **Short-time**  
 5 **(Symmetrical) Withstand Current Duration:** The maximum duration of short-time (symmetrical)  
 6 withstand current that a switch is required to carry.
- 7 **Short-time (Symmetrical) Withstand Current:** An abnormal power frequency current, the initial portion  
 8 of which may have a dc offset, expressed in rms symmetrical amperes that a switch is required to carry.
- 9 **Station Class:** A descriptive term used to denote application or restriction or both to generating stations,  
 10 switching stations, substations and transmission lines.
- 11 **Switch Part Class Designation:** A code that identifies the curve that relates the loadability factor (LF) of a  
 12 switch part material and function to the ambient temperature  $\theta_A$ .
- 13 **Switch:** Within this document, the noun "switch" shall refer to switching devices, interrupters, current  
 14 interrupting devices, interrupting aids or interrupter switches.
- 15 **Switching Impulse Withstand Voltage:** The crest value of a voltage impulse with a front duration from  
 16 tens to thousands of microseconds that, under specified conditions, can be applied without causing  
 17 flashover or puncture.
- 18 **Visible Corona:** A luminous discharge due to ionization of the air surrounding a device, caused by a  
 19 voltage gradient exceeding a certain critical value.

## 20 **4. Service conditions**

21 Refer to appropriate product standard.

## 22 **5. Description of ratings and capabilities**

23 Refer to appropriate product standard.

## 24 **6. Preferred ratings**

25 Refer to appropriate product standard.

## 1 **7. Construction requirements**

2 Refer to appropriate product standard.

## 3 **8. Test Code**

### 4 **8.1 Switching Tests**

5 Switching tests are performed to determine the adequacy of the design of a particular type, style, or  
6 model of switch or its component parts to meet its assigned switching abilities.  
7

#### 8 **8.1.1 General**

9 The switching abilities shall be stated in terms of

- 10 a) The test voltage
- 11 b) The test current
- 12 c) The test circuit
- 13 d) The number of operations

##### 14 **8.1.1.1 Condition of the switch to be tested**

15 The switch shall be new or in good condition.

##### 16 **8.1.1.2 Mounting of switch**

17 The switch shall be mounted in the usual service position for which it is designed. The base, or other  
18 normally grounded metal parts, shall be grounded, except as explained in the last paragraph below.

19 The interrupting ability of a switch that relies on a rapidly increasing external air gap for circuit  
20 interruption (such as whip arcing horns) may be dependent on mounting position. In this case,  
21 the mounting arrangement should be recorded to assist in the application of the device.

22 Due consideration shall be given to the choice of source side connections. When the switch is intended  
23 for power supply from both sides and the physical arrangement of one side differs from that of the other  
24 side, the live side of the test circuit shall be connected so as to represent the lowest dielectric strength. In  
25 case of doubt, some of the operations shall be carried out with the supply connected to one side and the  
26 remaining operations with the supply connected to the other side.

27 If the switch is to be rated for use in enclosures, the tests shall be made in the smallest enclosure for  
28 which the switch is intended to be used, OR the tests shall be made with metallic screens placed in the  
29 vicinity of the live parts and separated from them by a minimum clearance specified by the  
30 manufacturer. The enclosure, or screens, as well as the frame and other normally grounded parts shall be  
31 insulated from ground, but connected thereto through a suitable device to indicate current to ground  
32 greater than 3 Amps. A fuse consisting of a 5 cm (2 in) long #38 AWG copper wire is one method  
33 sufficient to detect current to ground in excess of 3 Amps.

### 1 8.1.1.3 Single-phase vs. three-phase testing

2 Interrupting tests on three-pole, gang-operated switches are preferably made three-phase at rated  
3 maximum voltage but may be made single-phase. However, the following standards may require three-  
4 phase testing:

- 5 - IEEE Std C37.20.2
- 6 - IEEE Std C37.20.3
- 7 - IEEE Std C37.20.4
- 8 - IEEE Std C37.74

9 Test voltages for single-phase tests to establish a three-phase rating are given in Table 1. Test voltages  
10 for single-phase tests to establish a rating “for systems with grounded sources and loads only”  
11 shall be computed by the formula:  
12

$$\frac{\text{rated maximum voltage}}{\sqrt{3}}$$

13  
14  
15 Single-phase testing to establish a three-phase rating performed on an integrally mounted three-pole  
16 switch shall be performed with the non-energized poles grounded.

17 Interrupting tests on single-pole switches (or single-pole switches combined in a three-pole assembly,  
18 but operated pole after pole) shall be performed single-phase at rated maximum voltage.

19

20 **Table 1 —Test voltages for single-phase tests to establish three-phase ratings**

Duty	Single-phase test voltage per unit of rated maximum voltage (unless otherwise noted)
Load Switching	$1.5 / \sqrt{3}$
Loop Switching	$1.5 / \sqrt{3}$ per unit of rated loop-switching voltage.
Unloaded Transformer Switching	1.0

21

22

### 23 8.1.1.4 Operating Mode

24 Tests shall be performed per the ratings of the device, interrupting, making or switching. Switching can be  
25 performed in any sequence. An unspecified time may be allowed to elapse between making the circuit and  
26 breaking it. The switch may be allowed an unspecified time to cool between operations.

27 Switches normally operated manually may be operated by remote control or power operating means,  
28 provided that an operating speed provided by the manufacturer is obtained. The operating method and  
29 duration of the operating cycle shall be included in the test report.

30 If the switch is power-operated, the switch operating device shall be operated in the manner specified by  
31 the manufacturer. In particular, if the switch is electrically, hydraulically, or pneumatically operated, and if  
32 the switch’s performance is affected by the operating voltage or fluid pressure, it shall be operated at

- 1           - Nominal voltage or fluid pressure for 60% of all operations of each applicable duty
- 2           - Minimum voltage or fluid pressure for 20% of all operations of each applicable duty
- 3           - Maximum voltage or fluid pressure for 20% of all operations of each applicable duty

#### 4   **8.1.1.5 Frequency**

5   The frequency of the supply voltage shall be defined by the appropriate product standard with a tolerance of  
6   +/- 5% of the specified frequency.

#### 7   **8.1.1.6 Test current**

8   The test current shall be as specified in the appropriate product standard. Allowable tolerance  
9   shall be -0%, +10%.

#### 10   **8.1.1.7 Power-frequency test voltage**

11   The power-frequency test voltage is the average of the phase-to-phase voltages, and shall be measured  
12   in the interval between 1 cycle and 1 1/2 cycle after the final phase arc-extinction.

13   The test voltage in the case of three-phase tests shall be equal to or greater than the rated maximum voltage  
14   of the switch, except for tests with closed loop breaking currents for which the test voltage shall be the rated  
15   loop-switching voltage. The individual phase voltages shall not vary more than  $\pm 10\%$  of the average value.  
16   Test voltages for single-phase tests shall be as specified in the appropriate product standard. The tolerance  
17   of the test voltage shall be -0%, +10%.

18   The rated power-frequency test voltage shall be maintained for at least 0.3 s after arc extinction.

#### 19   **8.1.1.8 Unit testing**

20   Subclause 4.8.2.3 of C37.09 – 1999 is applicable

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22  
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#### 25   **8.1.1.9 Information to be included in test report.**

26   The results of all type tests shall be recorded in type test reports containing sufficient data to prove  
27   compliance with the ratings and the test clauses of the relevant standards and sufficient information shall  
28   be included so that the essential parts of the switchgear and controlgear can be identified. In particular, the  
29   following information shall be included:

- 30           - manufacturer
- 31           - type, designation and serial number of the switchgear and controlgear tested
- 32           - rated characteristics of switchgear and controlgear tested as specified in the relevant standard
- 33           - general description (by manufacturer) of switchgear and controlgear tested, including number  
34           of poles
- 35           - manufacturer, type, serial numbers and ratings of essential parts, where applicable (for  
36           example, operating mechanisms, interrupters, shunt impedances)
- 37           - general details of the supporting structure of the switching device or enclosed switchgear of  
38           which the switching device is an integral part
- 39           - details of the operating mechanism and devices employed during tests, where applicable

- 1 - photographs to illustrate the condition of the switchgear and controlgear before and after test
- 2 - sufficient outline drawings and data schedules to represent the switchgear and controlgear
- 3 tested
- 4 - reference numbers of all drawings including revision number submitted to identify the
- 5 essential parts of the switchgear and controlgear tested
- 6 - details of the testing arrangements (including diagram of test circuit)
- 7 - statements of the behavior of the switchgear and controlgear during tests, its condition after
- 8 tests and any parts renewed or reconditioned during the tests
- 9 - records of the test quantities during each test or test duty, as specified in the relevant standard
- 10 Note NSDDs may occur during the recovery voltage period following a breaking operation.
- 11 Their number is of no significance to interpreting the performance of the device under test.
- 12 They should only be reported in the test report to differentiate them from restrikes.
- 13

## 14 **8.1.2 Test duties**

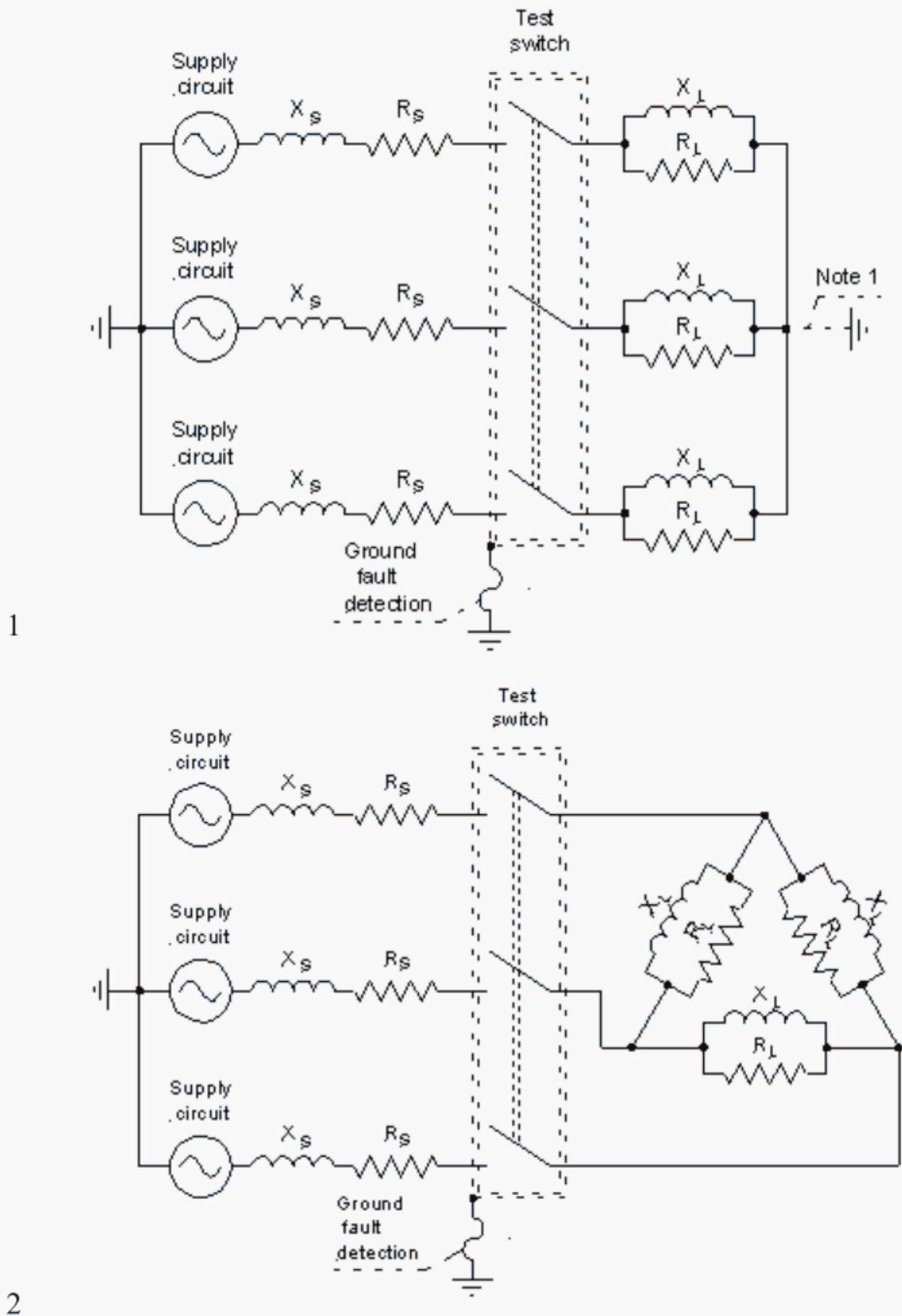
### 15 **8.1.2.1 Load-switching tests**

16 Making and breaking operations shall be randomly timed. For three-phase, group-operated switches, the  
 17 tests shall be made at the rated maximum voltage of the switch on a three-phase circuit with a parallel-  
 18 connected load having a power factor between 1.0 and 0.7 lagging (except as noted in next paragraph),  
 19 using one of the circuits shown in Figure 1. For single-phase or three-phase non-gang-operated switches,  
 20 the test shall be made at the voltage given in Table 1 on a single-phase circuit with a parallel-connected  
 21 load having a power factor between 1.0 and 0.7 lagging (except as noted in next paragraph), using the  
 22 circuit shown in Figure 2.

23 Testing at lower power factors is allowed if the resulting transient recovery voltage (TRV) is more severe  
 24 than that specified. (See Annex A.)

25 For rated current tests, the test current shall be the rated current  $-0, +10\%$ . For lower than rated current  
 26 tests, the source impedance ( $Z_s$ ) and TRV setting components shall be the same as for the 100% load tests.  
 27 For lower than rated current tests, a tolerance of  $\pm 10\%$  is allowed on the test current.

28



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3 Figure 1. Three-phase alternate test circuits for load current switching.

4 Notes to Figure 1.

5 1. Either the neutral of the load *or* the neutral of the source may be grounded but *not* both.

6 2.  $Z_S = 10\% \text{ to } 20\% \frac{\text{Rated maximum voltage}}{\sqrt{3} \text{ Rated switching current}}$

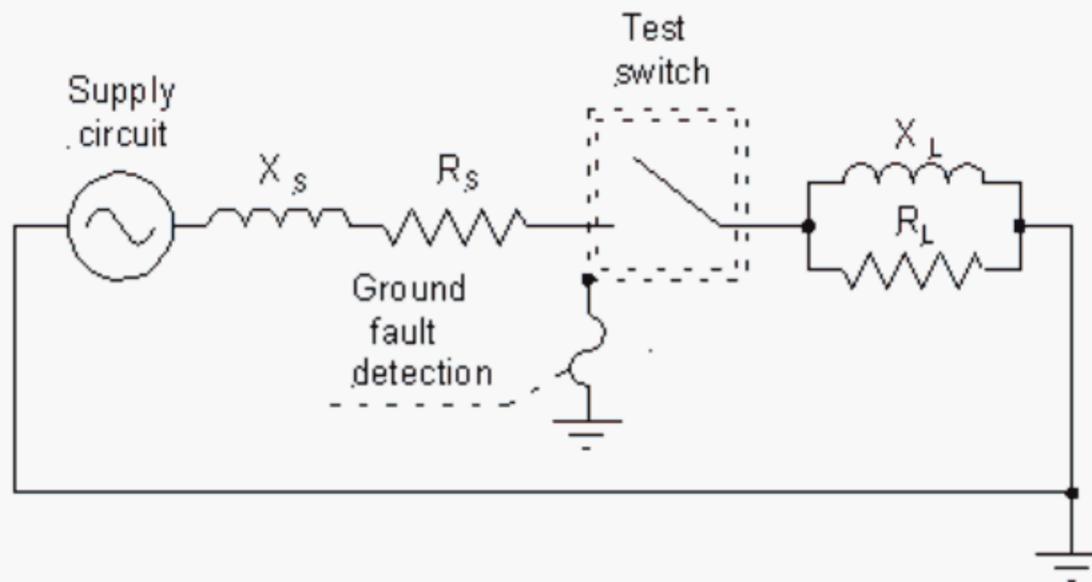
1 3.  $\frac{X_S}{R_S} = 5 \text{ to } 7$

2 4. Load power factor  $\text{PF}_L \geq 0.7$  i.e.  $\frac{X_L}{R_L} \geq 0.98$

3 5. Once calculated and set for 100% load switching test series,  $Z_S$  remains the same for the reduced load-  
4 switching current test.

5 6. TRV: per Figure 3 and Table 2.

6



7

8 Figure 2. Single-phase load current switching test circuit.

9 Notes to Figure 2.

10 1.  $Z_S = 10\% \text{ to } 20\% \frac{\text{Rated maximum voltage}}{\sqrt{3} \text{ Rated switching current}}$

11 2.  $\frac{X_S}{R_S} = 5 \text{ to } 7$

12 3. Load power factor  $\text{PF}_L \geq 0.7$  i.e.  $\frac{X_L}{R_L} \geq 0.98$

13 4. Once calculated and set for 100% load switching test series,  $Z_S$  remains the same for the reduced load-  
14 switching current test.

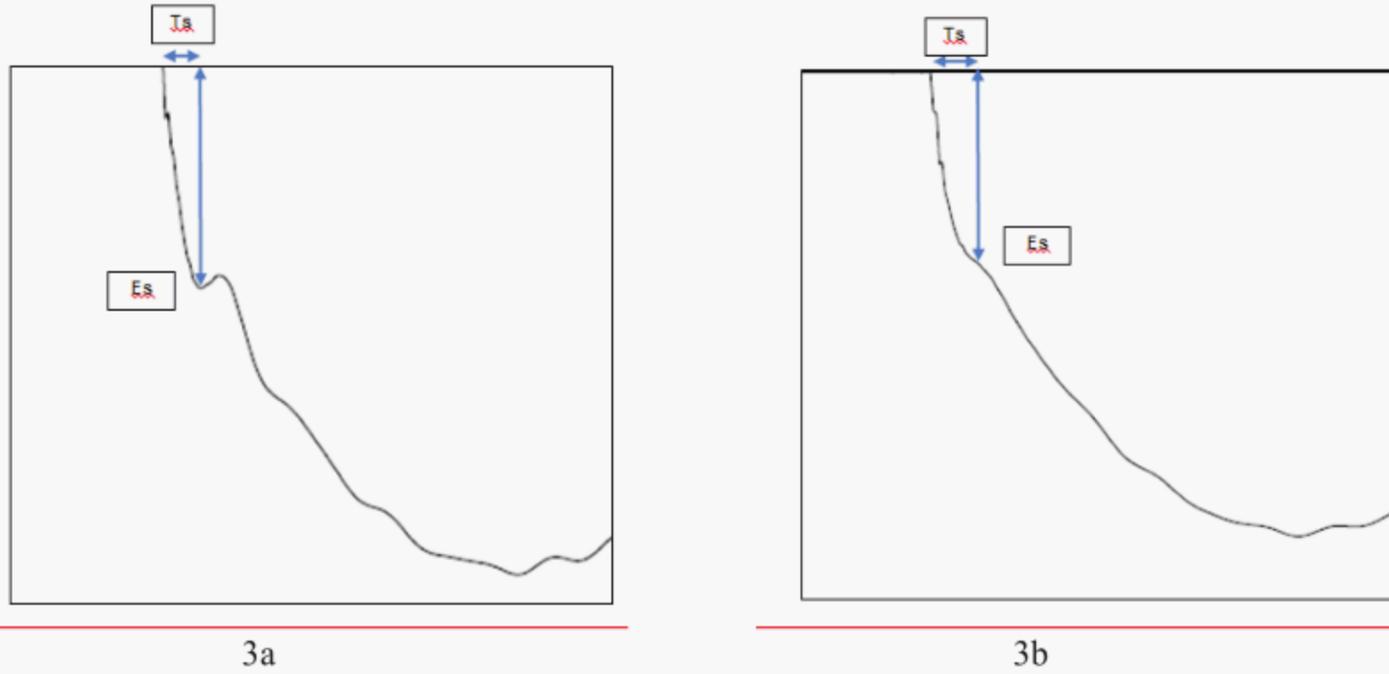
15 5. TRV: per Figure 3 and Table 2.

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- **Figure 3—Inherent total TRV for rated load-switching current tests**

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If the prospective TRV wave shape does not provide the distinctive oscillation shown in Figure 3a, the inherent total TRV defined in Table 2 is satisfied if the voltage value obtained at time  $T_s$  is equal to or greater than the value provided in Table 2 for a specified rated maximum voltage as shown in Figure 3b.

7  
8

Table 2 —Inherent total TRV parameters for rated load-switching current test

Rated maximum voltage (kV)	Minimum peak TRV $E_s$ (kV) <sup>1, 3, 4</sup>	Maximum time-to-peak $T_s$ ( $\mu$ s) <sup>2, 4</sup>
4.8	1.04	75
8.25	1.9	110
15.0	3.9	175
15.5	4.0	180
25.8	7.2	280
27	7.6	290
38	13	310
48.3	18	550
72.5	15	33
121	25	47
145	30	52
169	35	59
242	34	77
362	50	95
550	76	115
800	110	135

9  
10

1 Conditions applicable to Table 2 are shown below:

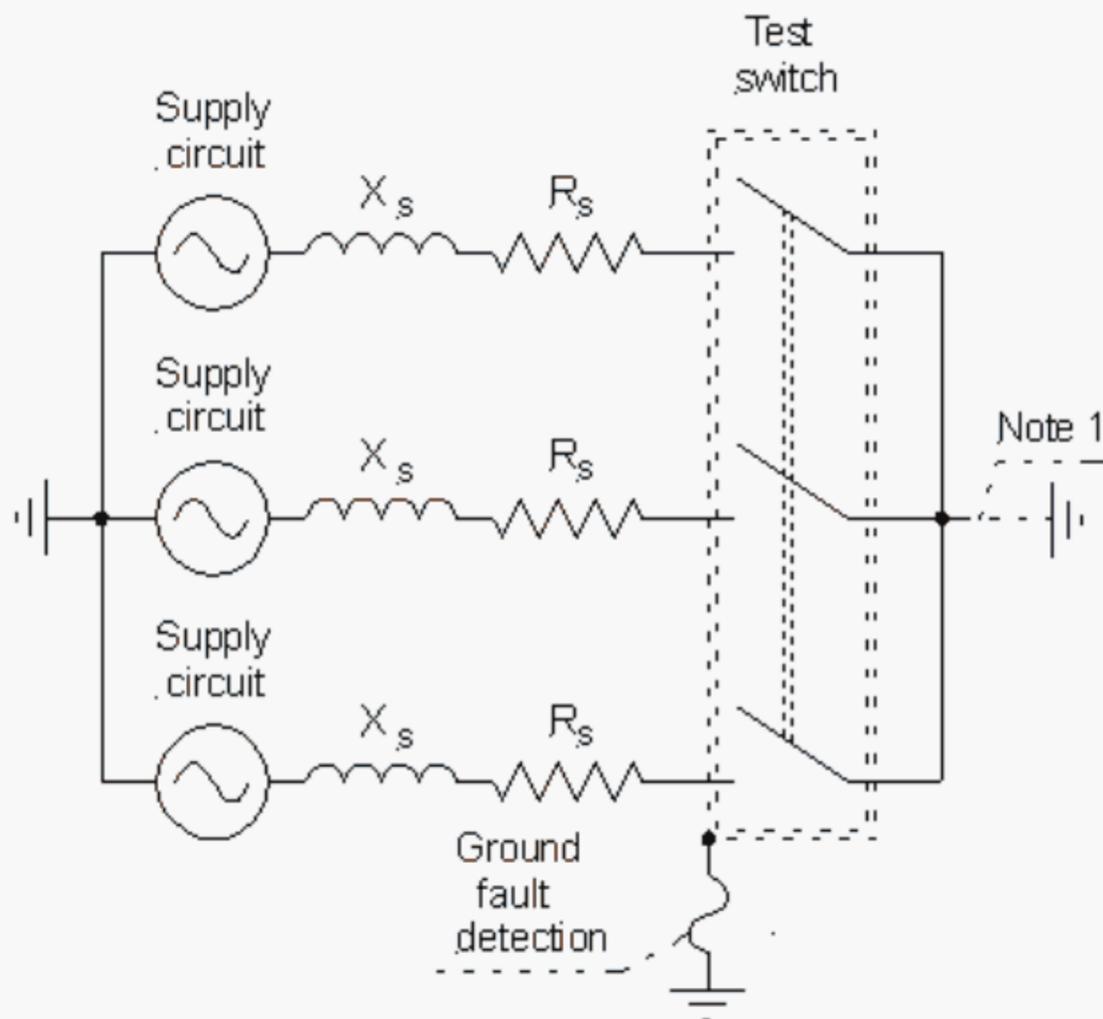
- 2 - 1.  $E_S$  values for distribution voltages (up to 48.3 kV) are based on: 10% source, 1.5 amplitude  
3 factor, and a 1.5 phase factor.
- 4 - 2. Time-to-peak values are based on the load-side TRV and source TRV frequencies from  
5 IEEE Std C37.41-1994 [B3], Table 3, which are indicative of substation TRV's with the  
6 system highly interconnected (note breaker TRV frequencies are based on a last device to  
7 clear and represented station TRV's with the system under normal conditions).
- 8 - 3. For transmission voltages (greater than 48.3 kV), the TRV parameters are based on IEC  
9 60265-2 (1988-03) [B4], modified to yield time-to-peak values rather than the IEC T3 values.
- 10 - 4. Interpolation for other rated voltages is permitted.

11 If the prospective TRV wave shape does not provide the distinctive oscillation shown in Figure 3, the  
12 inherent total TRV defined in Table 2 is satisfied if the voltage value obtained at time TS is equal to or  
13 greater than the value of ES provided in Table 2 for a specific rated maximum voltage.

#### 14 **8.1.2.2 Loop-switching Tests**

15 The switch shall be capable of making and interrupting all loop currents up to and including its rated loop-  
16 switching current. Making and breaking operations shall be randomly timed. For three-phase gang-operated  
17 switches, the tests shall be made at rated loop-switching voltage (refer to appropriate apparatus standard) of  
18 the switch on a three-phase circuit with a lagging power factor of less than 20%, using the circuit shown in  
19 Figure 4. For single-phase or three-phase non-gang-operated switches, the test shall be made at rated loop-  
20 switching voltage of the switch on a single-phase circuit with a lagging power factor of less than 30%,  
21 using the circuit shown in Figure 5.

22 Testing with a load-switching circuit (Figure 1 or Figure 2) that utilizes a 20%  $\pm$ 2% source impedance  
23 may be substituted for the loop-switching test.



1

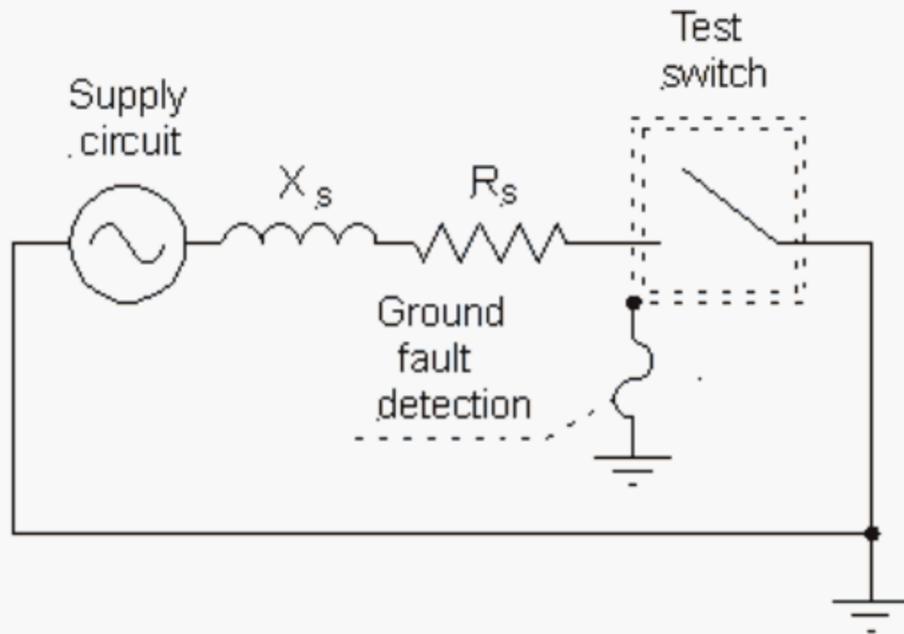
2 Figure 4. Three-phase loop current switching test circuit.

3 Notes to Figure 4.4 1. Either the neutral of the load *or* the neutral of the source may be grounded but *not* both.5 2. Power Factor  $PF \leq 0.2$  i.e.  $\frac{X_s}{R_s} \geq 4.9$ 

6 3. TRV: per Figure 6 and Table 3.

7 4. Part or all of the source impedance,  $R_s$  and  $X_s$  may appear on either side of the switch

8



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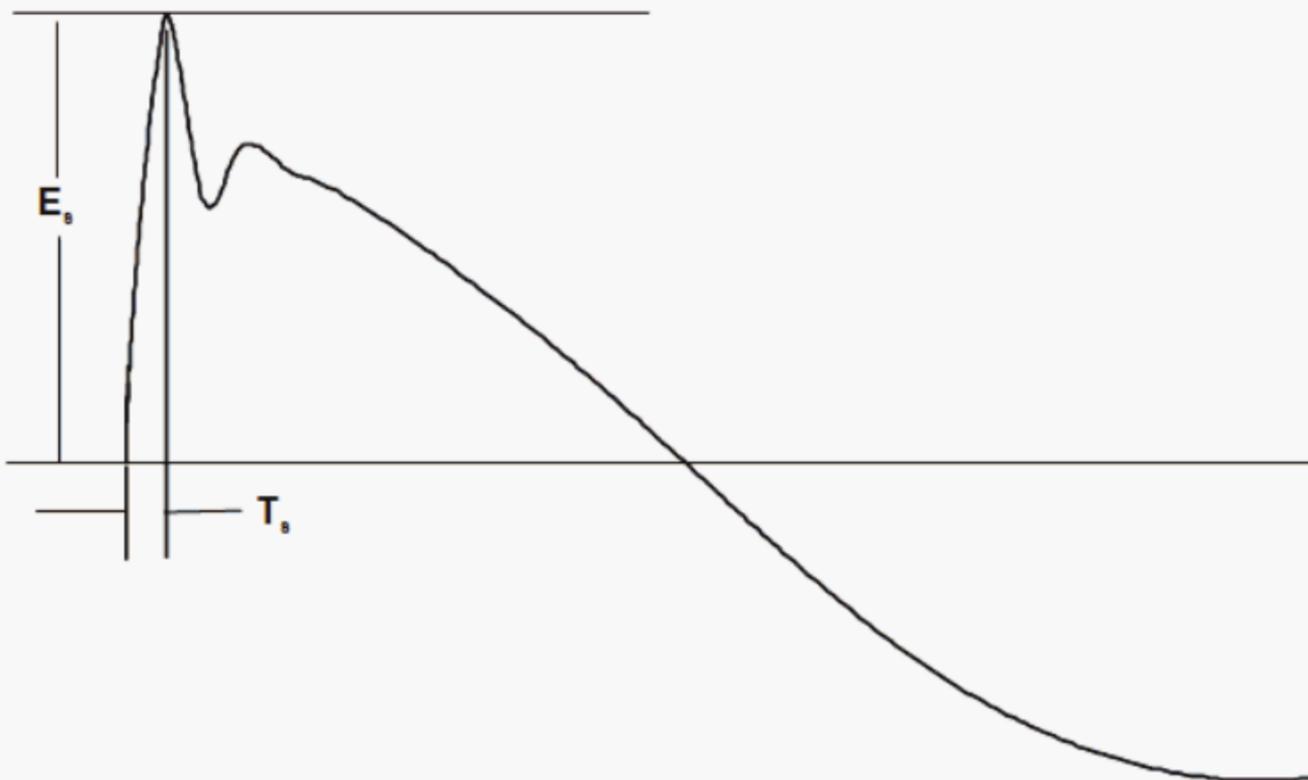
2 Figure 5. Single-phase loop current switching test circuit.

3 Notes to Figures 5.

4 1. Power Factor  $PF \leq 0.2$  i.e.  $\frac{X_s}{R_s} \geq 4.9$

5 2. TRV: per Figure 6 and Table 3.

6 3. Part or all of the source impedance,  $R_s$  and  $X_s$  may appear on either side of the switch



7

8 Note –  $E_s$  and  $T_s$  per Table 3 or 4

9 **Figure 6 —Loop-switching TRV first pole to open**

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11

1 **8.1.2.2.1 Line or cable loop-switching**

2 For the line or cable loop-switching test, the transient recovery voltage shall be equal to or greater than that  
3 specified in Table 3.

4 Note: This is a load current switching requirement and not to be considered as capacitor switching.

5 **Table 3—TRV parameters for line or cable loop-switching**

Rated voltage (kV) <sup>3</sup>	Minimum peak TRV,	Maximum time-to-peak, $T_s$
4.76	1.7	120
8.25	2.9	150
15.0	5.1	211
15.5	5.3	215
25.8	8.9	285
27	9.3	295
38	13	335
48.3	17	370
Rated voltage (kV)	Minimum peak TRV, $E_s$ (kV)	Minimum time-to-peak factor, $K_1^9$
72.5	29	0.267
121	48	0.267
145	57	0.267
169	66	0.267
242	95	0.267
362	107	0.205
550	165	0.205
800	240	0.205

6 Conditions applicable to Table 3 are shown below:

- 7 - 1.  $E_s$  values for distribution voltages are based on 20% recovery voltage, a 1.4 amplitude  
8 factor, and 1.5 phase factor.
- 9 - 2. The time-to-peak values are based on TRV frequencies IEEE Std C37.41-1994 [B3], Table  
10 6 and are representative of TRV's on distribution systems, away from substations.
- 11 - 3. Values for transmission voltages are based on IEC 60265-2 (1988-03) [B4], modified to  
12 yield time-to-peak values rather than the IEC T3 values.
- 13 - 4. Interpolation for other rated voltages is permitted.

14 <sup>9</sup>  $T_s = E_s / (K_1 \times I)$

15 **8.1.2.2.2 Parallel transformer loop-switching**

16 For the parallel transformer loop-switching test, the transient recovery voltage peak shall be equal to or  
17 greater than that specified in Table 4 and the time to peak shall be less than or equal to that specified in  
18 Table 4.

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**Table 4—TRV parameters for parallel transformer loop-switching**

Rated voltage (kV)	Minimum peak TRV,	Maximum time-to-peak
4.76	0.8	0.27
8.25	1.3	0.35
15.0	2.3	0.48
15.5	2.4	0.49
25.8	4.0	0.62
27	4.2	0.64
38	5.9	0.76
48.3	7.5	0.87
Rated voltage (kV)	Minimum peak TRV,	Maximum time-to-peak
72.5	11.5	1.05
121	19	1.35
145	23	1.48
169	27	1.60
242	26	1.91
362	38	2.34
550	58	2.88
800	84	3.48

4 Conditions applicable to Table 4 are shown below:

- 5 - 1.  $E_S$  values are based on a 1.7 amplitude factor, a 1.5 phase factor for non-grounded systems  
6 below 242 kV or a 1.0 phase factor for systems with grounded sources and loads at or above  
7 242 kV; and a transformer impedance of 15% based on its forced cooling rating.
- 8 - 2. Time-to-peak factor is based on TRV frequencies obtained by low voltage current-  
9 injection of transformers (see Harner, Rodriguez [B1]).
- 10 - 4. Interpolation for other rated voltages is permitted.

11  $^{10} T_S = K_2 \times \sqrt{(1480+1187xI) / (13.3 \times I)}$

12  $^{11} T_S = K_3 \times \sqrt{(1650+2240xI) / (13.3 \times I)}$

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2 **8.1.2.3 Unloaded transformer switching tests**

3 It is assumed that a switch that has passed the required load-switching tests will also interrupt unloaded  
4 transformer magnetizing currents corresponding to a distribution transformer, rated 38 kV or less and also  
5 rated 2500 kVA or less; therefore, no tests are specified.

6 Because of the variety of transformers and associated circuits, it is not possible to define a rated no-load  
7 transformer breaking current. Due to the non-linearity of the transformer magnetizing current core, it is not  
8 possible to correctly model the switching of transformer magnetizing current using linear components in a  
9 test laboratory. Tests conducted using an available transformer will only be valid for the tested transformer  
10 and cannot be representative of other transformers. If a special test is necessary, test circuits and test  
11 procedures have to be agreed between customer and manufacturer.

12 **8.1.3 Condition of the switch during the switching tests**

13 During operation, the switch shall neither show signs of excessive distress nor endanger the operator.

14 There shall be no outward emission of flame from liquid-filled switches and the gases produced together  
15 with the liquid carried with the gases shall be allowed to escape in such a way as not to cause electrical  
16 breakdown.

17 For other types of switches, flame or metallic particles that might impair the insulation level of the switch  
18 shall not be projected beyond the boundaries specified by the manufacturer.

19 There shall be no indication of current greater than 3 Amps to the grounded structure, or screens when  
20 fitted, during the tests.

21 **8.1.4 Condition of the switch after the switching tests**

22 The switch shall meet the conditions outlined in 8.6.

23 **8.2 Fault-making current test**

24 Fault-making current tests are performed to confirm the ability of the switch to close and carry short-time  
25 withstand current driven by a voltage up to its rated maximum voltage.

26 **8.2.1 General**

27 The fault-making current ability of a switch shall be stated in terms of the following:

- 28 - The test voltage
- 29 - The peak value of the fault-making current
- 30 - Speed of operation
- 31 - The rms value of the ac component of the fault-making current
- 32 - The fault-making current duration
- 33 - The number of fault making operations

34

1

**2 8.2.2 Test conditions**

3 The switch shall be mounted in the usual service position for which it is designed. The base, or other  
4 normally grounded metal parts, shall be grounded, except as explained for switch to be rated for use in  
5 enclosures (see 5th paragraph of this section). The switch shall be operated in the manner specified and in  
6 particular, if it is electrically, hydraulically, or pneumatically operated, operations shall be made at  
7 minimum voltage or fluid pressure and at maximum voltage or fluid pressure.

8 Switches with manual operation may be operated by remote control or power operating means, provided  
9 that the operating speed within 10% to that of the manual operator is obtained at contact make.

10 Due consideration shall be given to the choice of source side connections. When the switch is intended for  
11 power supply from both sides and the physical arrangement of one side differs from that of the other side,  
12 the live side of the test circuit shall be connected to the side that represents the most onerous conditions. In  
13 case of doubt, some of the operations shall be carried out with supply connected to one side and the  
14 remaining operations with the supply connected to the other side.

15 Fault-making current tests may be made three-phase (unless otherwise specified) or single-phase. Fault-  
16 making current tests on three-pole switches, where the pole-to-pole electromagnetic forces are expected to  
17 challenge the mechanical strength of the switch supports, and the poles of which are operated  
18 simultaneously, shall be made three-phase. The preferred test circuits are shown in Figures 7a and 7b.

19 If the switch is to be rated for use in enclosures, the tests shall be made in the smallest enclosure for which  
20 the switch is intended to be used, or the tests shall be made with metallic screens placed in the vicinity of  
21 the live parts and separated from them by a minimum clearance specified by the manufacturer. The  
22 enclosure, or screens, as well as the frame and other normally grounded parts, shall be insulated from  
23 ground but connected thereto through a suitable device to indicate any significant current to ground. A fuse  
24 consisting of a 5 cm (2 in) long #38 AWG copper wire is one method sufficient to detect significant current  
25 to ground.

**26 8.2.3 Conditioning of the test sample**

27 The switch shall be conditioned prior to performing the fault-making current test. This shall consist of

28 10 close/open operations of the switching duty for which the switch has the highest rated current as outlined  
29 in 8.1, or the switch may be subjected to the total test sequence as outlined in 8.1.2.

30 If it is evident or if it can be proven that the fault-making current is not influenced by conditioning, for  
31 testing convenience, the fault-making current test may be made on a new switch of the same type.

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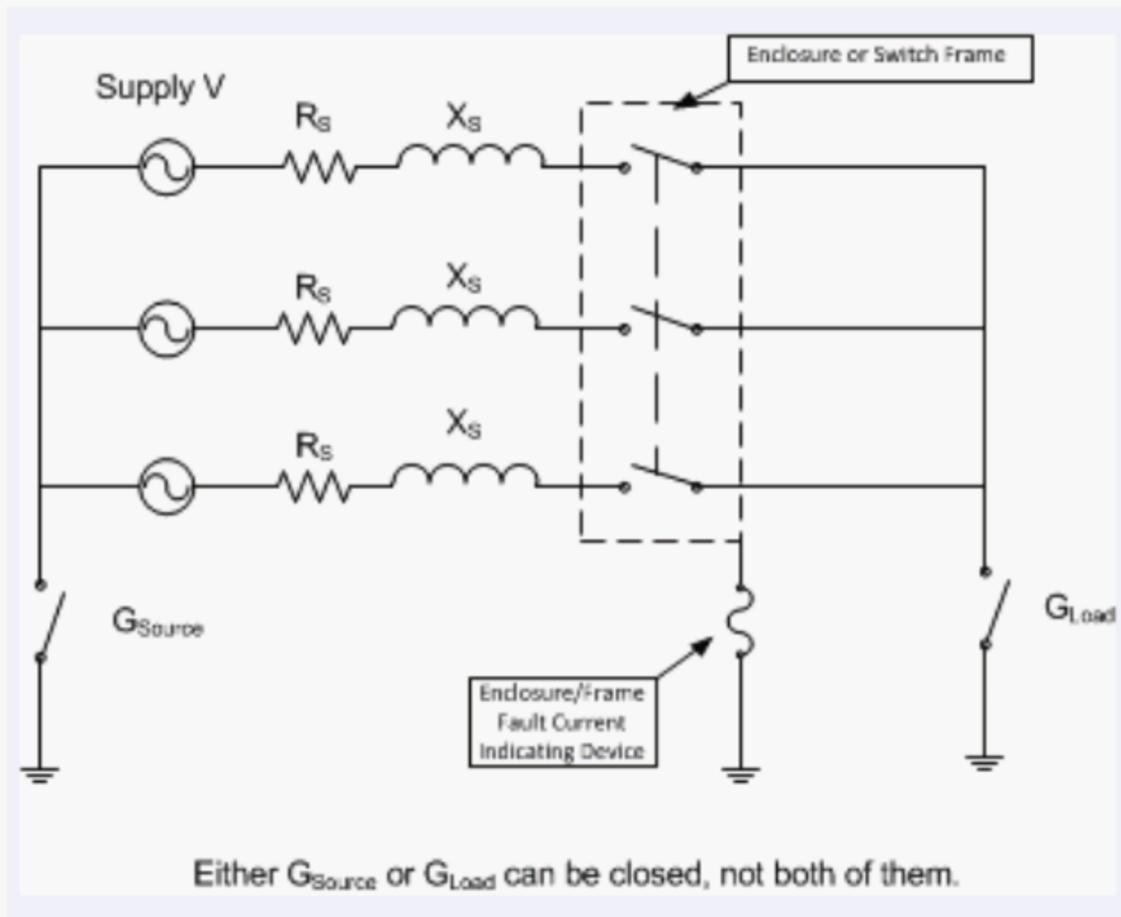
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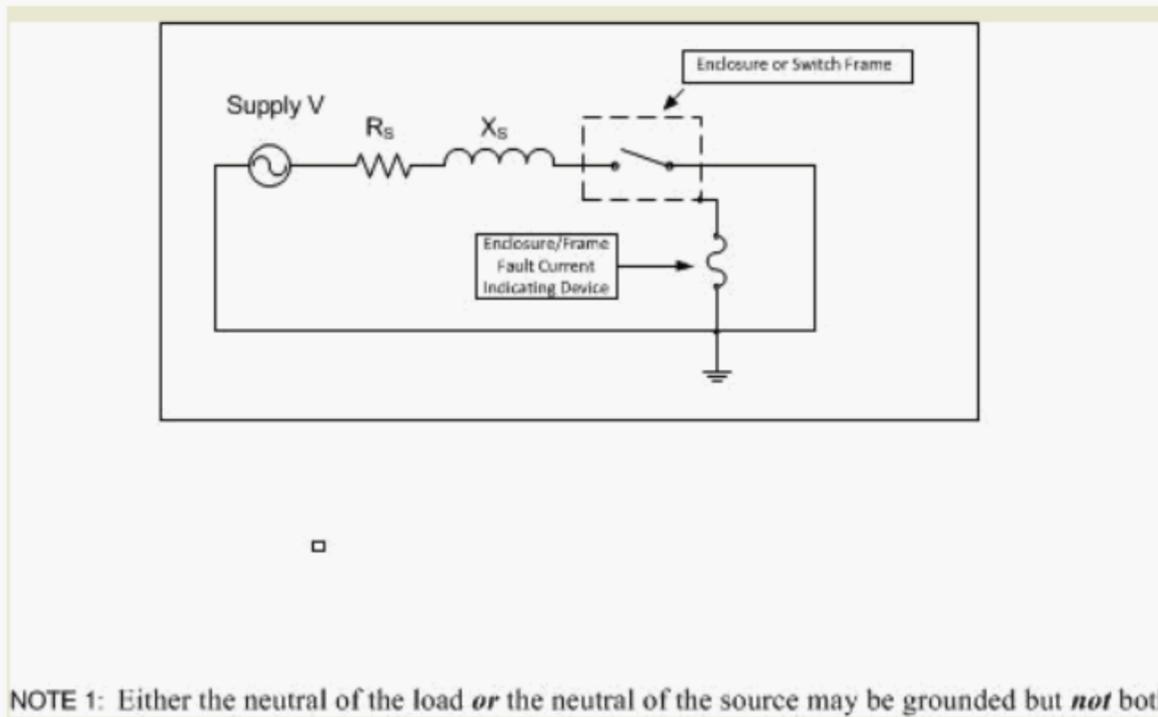
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4 Figure 7a. Three-phase test circuit for fault-making current tests.

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6  
7 Figure 7b. Single-phase test circuit for fault-making current tests.

8 **8.2.4 Test procedure**

9 **8.2.4.1 Frequency**

1 The frequency of the applied voltage shall be the rated power frequency of switch being tested with a  
2 tolerance of  $\pm 2\%$ .

### 3 **8.2.4.2 Applied voltage for fault-making current test**

4 The applied voltage for the fault-making current test is the rms value of the rated maximum voltage  
5 immediately before current flow.

6 In the case of three-phase tests, the average value of the applied voltages shall not be less than the rated  
7 voltage and shall not exceed this value by more than 10%.

8 The difference between the average value and the applied voltages of each phase shall not exceed 5% of the  
9 average value.

10 For single-phase or three-phase non-gang-operated switches, the applied test voltage shall not be less than  
11 the rated voltage of the switch.

### 12 **8.2.4.3 Current magnitude**

13 The peak fault-making current shall be no less than 2.6 times the rated rms symmetrical fault-making  
14 current. When testing a three-pole device with a single-phase circuit, the return current path shall be  
15 positioned such that forces equivalent to those produced with a three-phase circuit are generated in an  
16 outside pole.

### 17 **8.2.4.4 Degree of asymmetry**

18 For three-phase testing, at least one phase shall have peak current of the first major current loop equal to 2.6  
19 times the rated rms symmetrical fault-making current, except as noted below. For single-phase or three-  
20 phase non-gang-operated switches, the tests shall be repeated until at least one phase experiences a peak  
21 current of the first major current loop equal to 2.6 times the rated rms symmetrical fault- making current,  
22 except as noted below.

23 Due to pre-arcing it is not always possible to reach the peak current value; in this case, the current shall be  
24 considered satisfactory if the prospective peak current of the test circuit is equal to or greater than 2.6 times  
25 the rated rms symmetrical fault-making current.

### 26 **8.2.4.5 Duration of current flow**

27 The duration of the current flow shall be no less than 10 cycles.

### 28 **8.2.5 Condition of the switch after the fault-making current test**

29 During the test, the switch shall have functioned without failure and without maintenance or replacement of  
30 parts.

31 After performing the specified making test duties, arcing contacts or any other specified renewable parts  
32 may be worn. The quality of the oil, used for arc extinction in oil switches, may be impaired and its  
33 quantity reduced from the normal level. There may be deposits on insulators caused by the decomposition  
34 of the arc extinguishing medium.

35 The switch shall be capable of operating normally, carrying its rated continuous current without  
36 experiencing a thermal runaway. Unless the current tests have consumed the switch's life, as defined by the  
37 switch manufacturer, the switch shall be capable of performing its rated switching duties. The switch shall  
38 be capable of withstanding 80% of the power- frequency dry withstand voltage for one minute. Visual  
39 inspection and no- load operation of the used switch after tests are usually sufficient for checking these

1 requirements. For switches having contact structures not readily visible, a no-load open-close operation  
2 should be performed followed by a contact resistance check to determine the switch's current carrying  
3 ability, with a direct current of at least 100 amperes. The value of contact resistance shall be less than 200%  
4 of that before the test.

5 If the switch has not passed the resistance test:

6 - A continuous current test with no thermal runaway shall be performed at rated current.  
7 Thermal runaway means that the temperature does not stabilize and continues to increase as a  
8 trend.

9 - A rated power-frequency dry withstand voltage test shall be performed in the open position by  
10 applying 80% of the rated power-frequency dry withstand voltage to each terminal with all  
11 other terminals grounded.

12 There shall be no indication of current greater than 3 Amps to the grounded structure, or screens when  
13 fitted, during the tests.

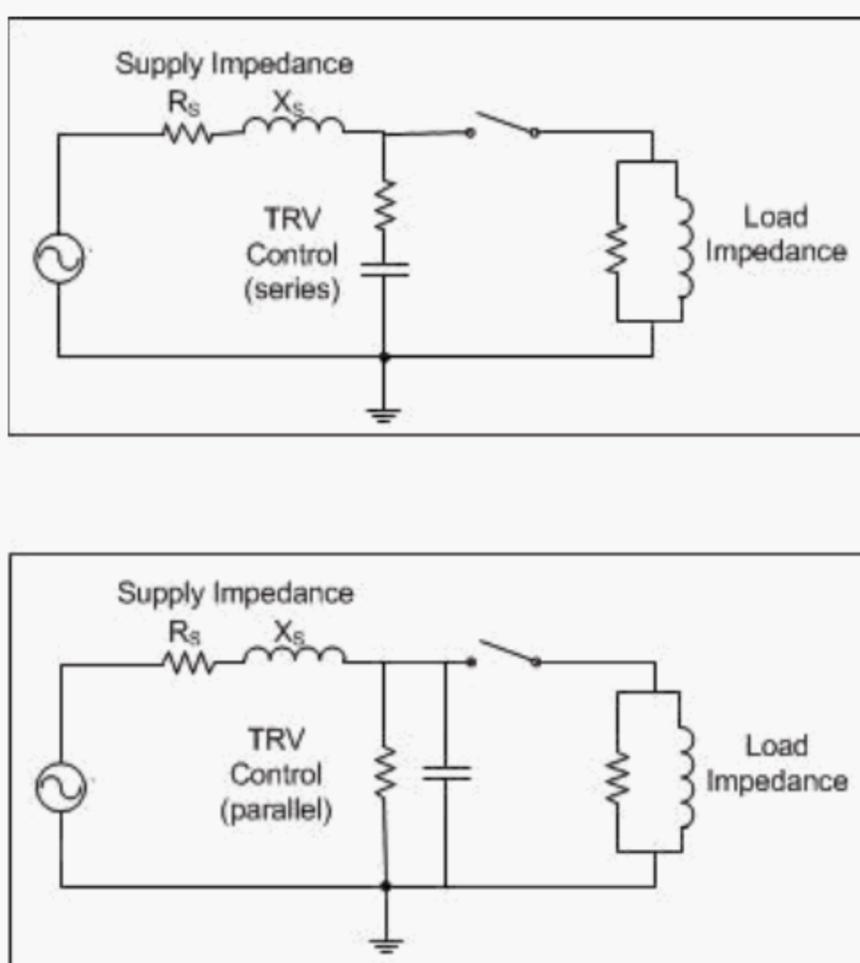
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# 1 Annex A

2 (informative)

## 3 Load-switching TRV

4 The Electromagnetic Transient Program (EMTP) study illustrates the effect that the power factor of a load  
 5 has on the TRV associated with load-switching. The study is based on the TRV parameters for 27 kV load-  
 6 switching, but the trend thus illustrated is applicable to all voltage classes. The TRVs shown below were  
 7 generated utilizing the EMTP to model the circuit of Figure A.1 utilizing parameters in Table A.1.



8

9

**Figure A.1—Circuit diagram used for switching simulation**

10 The TRVs generated by the EMTP program are shown in Figure A.2. Note that the initial portion of the  
 11 TRV is virtually the same for power factors between 1.0 and 0.8. The initial recovery peak is substantially  
 12 higher for unity power factor, making it the most severe TRV of the lot.

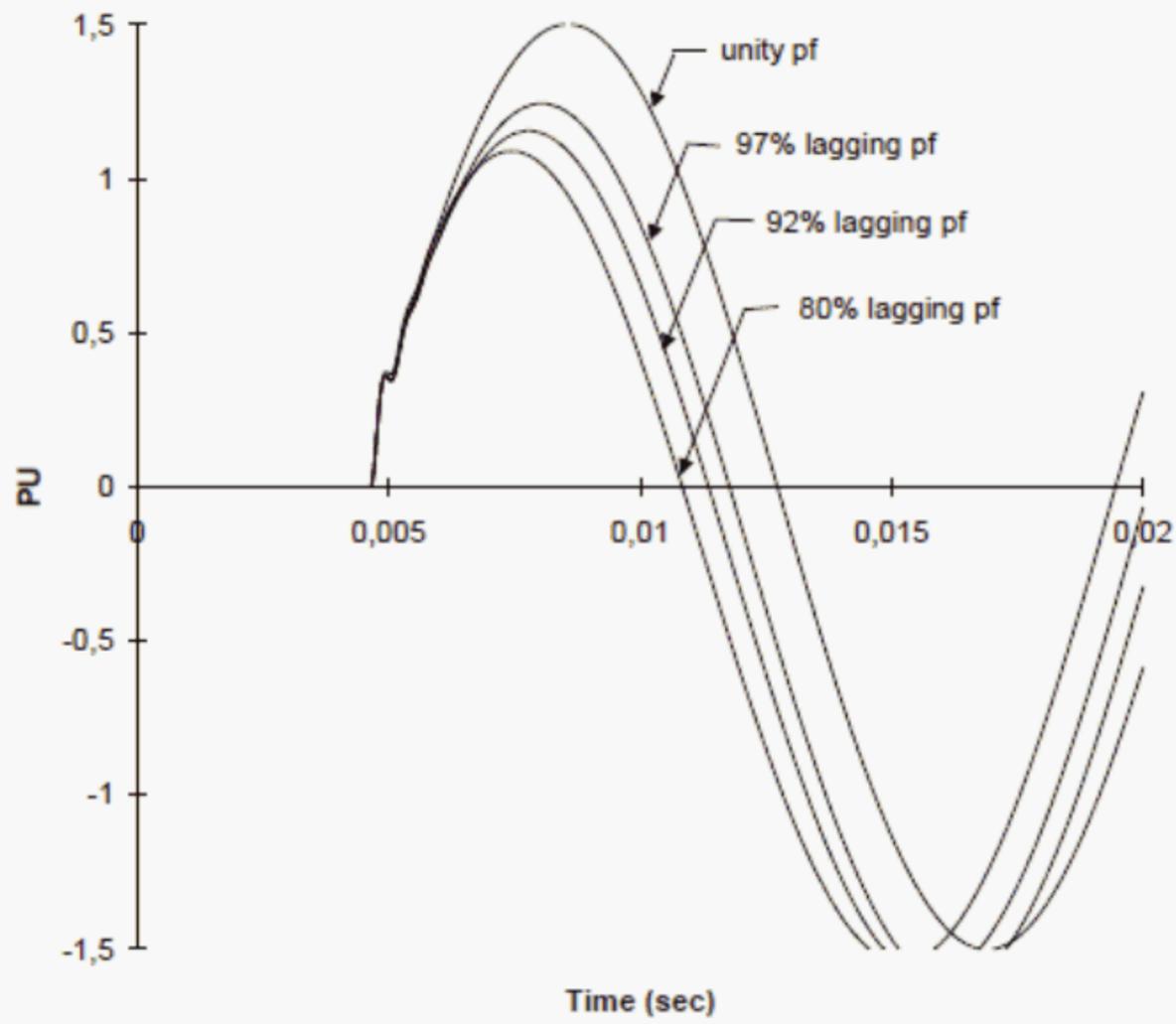
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**Table A.1—Values used to compute EMTP circuit elements<sup>12</sup>**

14

Load power factor	Source	Load	TRV resistor	TRV capacitor
Unity	$0.00583 + j 0.0991$	0.991	8.53	$-j 136.4$
97% lag	$0.00569 + j 0.0968$	$0.939 + j 0.235$	8.33	$-j 133.2$
92% lag	$0.00561 + j 0.0954$	$0.878 + j 0.374$	8.216	$-j 131.4$
80% lag	$0.00551 + j 0.0937$	$0.749 + j 0.562$	8.06	$-j 128.9$

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Figure A.2 – Switch recovery voltage for various load power factors

3

1 **Annex B**

2 (informative)

3 **Test Code Comparison 1247 vs C37.30.4/D8**

<b>IEEE 1247</b>	<b>C37.30.4/D8</b>
8.1 Withstand voltage tests	Not included in C37.30.4 (Included in C37.30.1)
8.2 Continuous current tests	Not included in C37.30.4 (Included in C37.30.1)
8.3 Switching tests	8.1 Switching tests included
8.3.1 General	8.1.1 General included
8.3.1.1 – 8.3.1.7	8.1.1.1 – 8.1.1.7 Included
8.3.1.8 Test sequence (including Table 5)	Not included (moved to C37.30.3)
8.3.1.9 Unit testing	8.1.1.8 Unit testing included (simplify to C37.09)
8.3.2 Test duties	8.1.2 Test Duties included
8.3.2.1 Load-switching tests	8.1.2.1 Load-switching tests included
8.3.2.2 Loop-switching tests	8.1.2.2 Loop-switching tests included
8.3.2.2.1 Line or cable loop-switching	8.1.2.2.1 Line or cable loop-switching included
8.3.2.2.2 Parallel transformer loop-switching	8.1.2.2.2 Parallel transformer loop-switching included
8.3.2.3 Cable-charging switching tests	Not included in C37.30.4 (Included in C37.100.2)
8.3.2.4 Line-charging switching tests	Not included in C37.30.4 (Included in C37.100.2)
8.3.2.5 Unloaded transformer switching tests	8.1.2.3 Unloaded transformer switching tests included
8.3.2.6 Shunt capacitor switching tests	Not included in C37.30.4 (Included in C37.100.2)
8.3.3 Condition of the switch during switching tests	8.1.3 Condition of the switch during switching tests included
8.3.4 Condition of the switch after the switching tests	8.1.4 Condition of the switch after the switching tests included
8.4 Short time withstand current tests	Not included in C37.30.4 (Included in C37.30.1)
8.5 Fault-making current tests	8.2 Fault-making current tests included
8.6 Condition of the switch after each test of 8.3, 8.4 and 8.5	8.2.5 Condition of the switch after fault-making tests
8.7 Ice loading test	Not included in C37.30.4 (Included in C37.30.1)
8.8 Mechanical operations tests	Not included in C37.30.4 (Included in C37.30.1)
8.9 Corona tests	Not included in C37.30.4 (Included in C37.30.1)
8.10 Radio-influence voltage tests	Not included in C37.30.4 (Included in C37.30.1)
8.11 Partial discharge test	Not included in C37.30.4 (Included in C37.30.1)
8.12 Production tests	Not included
Annex A – Altitude correction factors	Not included
Annex B – Load-switching TRV	Included as Annex A – Load-switching TRV included
Annex C – Restrike-free performance	Not included
Annex D – Capacitive current switching	Not included

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- 8 [B3] IEEE Std C37.41-1994, IEEE Standard Design Tests for High-Voltage Fuses, Distribution Enclosed  
9 Single-Pole Air Switches, Fuse Disconnecting Switches and Accessories.  
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